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## Phonon-driven transient bandgap renormalization in perovskite single crystals†

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Tailoring the electronic structure of perovskite materials on ultrafast timescales is expected to shed light on optimizing optoelectronic applications. However, the transient bandgap renormalization observed upon photoexcitation is commonly explained by many-body interactions of optically created electrons and holes, which shrink the original bandgap by a few tens of millielectronvolts with a sub-picosecond time constant, while the accompanying phonon-induced effect remains hitherto unexplored. Here we unravel a significant contribution of hot phonons in the photo-induced transient bandgap renormalization in MAPbBr<sub>3</sub> single crystals, as evidenced by asymmetric spectral evolutions and transient reflection spectral shifts in the picosecond timescale. Moreover, we performed a spatiotemporal study upon optical excitation with time-resolved scanning electron microscopy and identified that the surface charge carrier diffusion and transient bandgap renormalization are strongly correlated in time. These findings highlight the need to re-evaluate current theories on photo-induced bandgap renormalization and provide a new approach for precisely controlling the optical and electronic properties of perovskite materials, enabling the design and fabrication of high-performance optoelectronic devices with exceptional efficiency and unique properties.

## Introduction

Lead-halide perovskites have attracted significant attention in recent years in various optoelectronic applications, such as

### New concepts

In this study, we have demonstrated the significant role of phonons in the photo-induced transient bandgap renormalization (BGR) of MAPbBr<sub>3</sub> perovskite single crystals, in addition to the contribution from photo-generated hot carriers. This finding provides insights into the fundamental origin of the observed asymmetric spectral evolutions and shifts in transient optical spectroscopy. Moreover, we performed a comprehensive spatiotemporal analysis using state-of-the-art time-resolved scanning electron microscopy. Our results revealed that the excited carriers exhibited diffusion over a distance of approximately 7 μm within 2 ns, with the majority of diffusion occurring within ~250 ps. Notably, this diffusion time scale coincided perfectly with the phonon-driven BGR observed in our ultrafast spectroscopy measurements, suggesting that the carrier transport behavior, which is influenced by carrier mobility and concentration, can be altered during both nonequilibrium and equilibrium carrier-phonon interactions. Our research provides a novel strategy for precise control over the optical and electronic properties of perovskite crystals, and this knowledge can be harnessed to design and produce high-performance perovskite-based optoelectronic devices.

quantum light sources,<sup>1</sup> photovoltaics,<sup>2</sup> photodetectors,<sup>3</sup> and light-emitting diodes,<sup>4</sup> because of their extraordinarily long charge carrier lifetimes and diffusion lengths.<sup>5–7</sup> Ultrafast spectroscopy enables the measurement of photoexcitation-induced excited-state spectral evolution in real time, while polycrystalline perovskites exhibit spectral features that originate from the localized charge trapping at the impurities and/or defects and hinder the identification of the electronic structures.<sup>8,9</sup> Thus, single-crystal grain-free materials with low defect densities are employed to explore and decipher the intrinsic bulk behaviour of perovskites, free from morphological effects.<sup>10,11</sup>

Many-body effects and strong Coulomb interactions occurring after photoexcitation lead to intrinsic bandgap shrinking.<sup>12,13</sup> Although this phenomenon is commonly observed in various semiconductor materials, its overall behaviour is dictated by the competition among several different effects, and the exact origin and mechanism remain unclear. Transient spectroscopic characteristics induced by femtosecond (fs) pump and probe laser

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pulses are sensitive to the initial ultrafast dynamics of photo-generated electron-hole pairs.<sup>14</sup> Following photoexcitation, the non-thermal electron-hole distribution typically thermalizes on a sub-picosecond (ps) timescale.<sup>15</sup> The initial carrier cooling process is primarily governed by Coulomb-mediated scattering with optical phonons, known as Fröhlich interactions, followed by the less-efficient acoustic phonon scattering driven by deformation potentials.<sup>16</sup> These photo-generated charge carriers can ultimately shift the band edge by a few millielectronvolts (meV) within a few ps.<sup>17,18</sup> Controlling the electronic properties of materials through these many-body effects is successful but only at ultra-low temperatures.<sup>19,20</sup> It was reported that in a two-dimensional (2D) semiconductor,<sup>21</sup> room temperature transient absorption (TA) measurements exhibit excitation-density-dependent bandgap renormalization (BGR), which can be explained in terms of repulsive/attractive exciton-exciton interactions at high/low densities. However, the effect of lattice heating *via* phonon emission is typically disregarded in such cases. Upon photoexcitation, the collisions between electrons and thermally excited lattice vibrations (electron-phonon scattering) play a crucial role in energy transfer.<sup>22</sup> Thus, the lattice temperature can potentially affect the carrier distribution and even the electronic structure. Temperature-dependent steady-state photoluminescence (PL) spectra of perovskites exhibit a continuously blueshift of the emission peak with increasing temperature,<sup>23–26</sup> while the exact mechanism underlying this phenomenon is still debated. It is noteworthy that all current PL measurements are performed at low temperatures. Therefore, it is crucial to consider the contribution of hot phonons and quantify the impact of electronic and thermal effects on BGR after photoexcitation.

Moreover, directly visualizing the charge carrier diffusion behaviour of perovskites as well as identifying the fundamental physical mechanisms that determine their performance, are of considerable research interest. Thus far, electron-hole diffusion lengths, mostly probed *via* indirect methods such as time-resolved PL spectroscopy, have been reported to be in the micrometre range.<sup>5,6</sup> However, direct spatiotemporal mapping of charge carrier diffusion lengths using TA microscopy, which provides bulk information, has only been reported in fs-scale.<sup>27</sup> Ultrafast scanning electron microscopy (SEM), which is sensitive to the uppermost layer (a few to several nm) of a material's surface, has been employed to visualize the charge carrier transport with high spatial resolution in the time-domain.<sup>28–32</sup> Further, correlating charge carrier diffusion in a material with alterations to its electronic properties on ultrafast timescales would offer key elements for new material design and discovery for high-performance optoelectronic devices.

In this study, we conducted a systematic investigation to elucidate the effects of hot carriers and phonons on photo-induced BGR in MAPbBr<sub>3</sub> single crystals, serving as a model system. Our experimental approach involved a pump-energy and fluence-dependent ultrafast optical spectroscopy, complemented by temperature-dependent steady-state measurements. Our findings clearly demonstrate that, in addition to the contribution from photo-generated hot carriers, phonons also play a significant role in BGR. High-temperature PL and absorption

spectra showed consistent band-edge shifting patterns with those observed in transient spectroscopic analysis. Density functional theory (DFT) calculations further confirmed the dependence of the observed bandgap broadening on lattice-expansion. Furthermore, the ultrafast SEM study revealed that excited carriers diffused over a distance of approximately 7  $\mu\text{m}$  within a time frame of 2 ns, with the majority of diffusion occurring within  $\sim 250$  ps.

## Results and discussion

The fs-broadband transient absorption/reflection set-up and MAPbBr<sub>3</sub> single-crystal sample (size:  $\sim 5\text{ mm} \times 5\text{ mm} \times 2\text{ mm}$ ) fabrication methods are described in the ESI† and Methods section. Fig. 1 shows the time-energy transient reflection (TR) maps obtained after different time delays and the corresponding TR and normalized spectra obtained upon 3.10 eV excitation. The red and blue colours indicate the positive and negative TR signals, respectively, while the dashed lines represent the zero-crossing points ( $\Delta\text{OD} = 0$ ) at each delay time between the pump and the probe. Initially (stage-i) in Fig. 1a, b, and c, spectral broadening is observed immediately after the photoexcitation within the first few hundreds of fs, accompanied by an isosbestic point on the blue side of the spectral traces. At a later stage (stage-ii) in Fig. 1d, e, and f, there is a significant spectral redshift and narrowing with a delay time of hundreds of ps. The zero-crossing point shifts by  $\sim 14$  meV from 1 to 200 ps, and the full width at half maximum (FWHM) of the bleach narrows from  $\sim 63.8$  meV at 1 ps to  $\sim 57.1$  meV at 200 ps. Subsequently, the spectra exhibit a slight narrowing with no shift, as evidenced by the isosbestic point at  $\Delta\text{OD} = 0$  (the dashed circle in Fig. 1h, stage-iii), up to nanoseconds (ns) order. The derivative-like spectral response, characterized by positive values above  $\sim 2.35$  eV and negative values below this energy, has been well studied and assigned to the excitonic feature induced by bandfilling.<sup>33–36</sup> In contrast, the positive feature exhibits a significant asymmetric evolution and differs from the measurements conducted in transmission mode on thin films.<sup>34,37</sup> The TR spectra in this regime cannot be explained solely by band filling;<sup>38</sup> the presence of free carriers (continuum transitions) also contributes to the bleach of excitonic transitions. Further, the positive feature shows a carrier density dependence distinct from that of the bleach, indicating that it can serve as an indicator of the temperature effect in the material system.<sup>38</sup> Briefly, the prominent spectral redshift observed in stage-ii (Fig. 1d, e, and f) can be attributed to the photo-induced change of refractive index, BGR, and Burstein-Moss effect (band filling),<sup>34,39,40</sup> although the latter leads to a blueshift by shifting the reflection/absorption onset to higher energies.

The BGR is strongly affected by the carrier-carrier interaction,<sup>41,42</sup> and the excess energy of the excitation light can determine the extent of the bandgap narrowing, which is confirmed by the pump-energy-dependent TR spectra shown in Fig. 2. Ultrafast 2D pump-probe transient maps at different delay times (0.5, 1, 50, and 200 ps) under an identical pump





**Fig. 1** Time–energy map, representative spectral traces, and the corresponding normalized spectral traces obtained under 3.10 eV photoexcitation: (a)–(c) very early timescale (stage-i), (d)–(f) middle timescale (stage-ii), and (g)–(i) late timescale (stage-iii). The red colour indicates positive signals, blue indicates negative signals, white represents the zero-signal region, and dashed lines in the middle of the maps show the zero-crossing points at each time delay. At stage-i, there is an isosbestic point, which implies that no spectral shift occurs within this time window. The black arrow in figure (e) shows the significant spectral redshift with a delay time of 1 to 200 ps. An isosbestic point again appears after 400 ps in figure (h) at stage-iii.

power are displayed in Fig. 2a–d. All the transients are characterized by a derivative-like signal over the probe range, and two long-lived features are distinctly visible at the positive/negative signal maxima at all the pump energies. The horizontal black dashed line across the four maps represents the reference of the spectral shift with the delay time and pump energies. Fig. 2e shows the spectral cuts of 1 ps for different pump photon energies, with each trace normalized with respect to the minimum of the bleach at  $\sim 2.32$  eV. With increasing pump photon energy, the entire spectrum shifts toward the high-energy side, accompanied by a broadening of the bleach signal. The zero-crossing point shifts with the delay time and pump photon energies are plotted in Fig. 2f, in which the solid lines represent the linear fit of the energy positions at  $\Delta OD = 0$ . These points are clearly nonlinear with the increasing pump photon energies, and the linear fitting has been shown here only to indicate the trend. The vertical red lines indicate the spectral shift energy from 0.5 to 200 ps at each pump photon energy. Within this time period, the zero-crossing point moves 11.2 and 36.6 meV under 2.76 and 3.54 eV excitations, respectively.

The huge spectral shift observed in the TR spectra cannot be solely attributed to carrier–carrier interaction, considering the timescale involved, which exceeds the rapid cooling of the “hot” carriers (referred to as “hot” due to their initially high temperatures, reaching up to thousands of degrees<sup>18</sup>). Instead, the complete restructuring of the reflection-edge occurs within a timeframe corresponding to phonon scattering processes.<sup>36</sup> Thus, we next performed a pump-fluence-dependent TR experiment under 3.10 eV excitation with fluences ranging from  $101.9 \mu\text{J cm}^{-2}$  to  $611.2 \mu\text{J cm}^{-2}$ . The signal intensities at the maximum bleach positions of  $\sim 2.32$  eV show a linear relationship with the pump fluence (Fig. S1, ESI†), thereby confirming that the samples are robust within our excitation power range. Fig. 3a shows the normalized spectral traces cut at 1 ps, and the zero-crossing point shifts at each delay time and pump fluence are depicted in Fig. 3b. With the increasing pump fluence, which generates more hot carriers in the material,<sup>43</sup> the overall spectral profile remains the same but becomes broader, especially on the blue side. From 1 to 50 ps of delay times, the spectra shift to high energies with the increasing pump fluence,





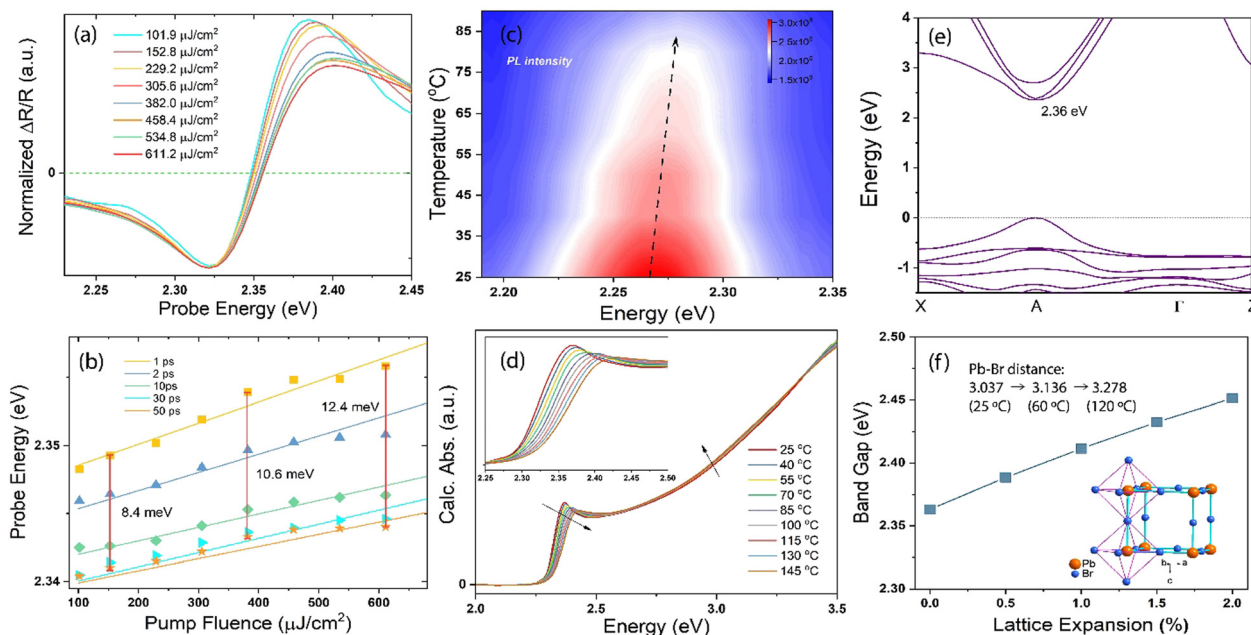
Fig. 2 (a)–(d) Transient spectral responses at 0.5, 1, 50, and 200 ps delay times as functions of the pump and probe photon energies. The scale bars are identical for all four maps, and the white colour in the maps indicates the zero-signal ( $\Delta OD = 0$ ) regions, whereas the horizontal black dashed line is the reference of the spectral shift with the delay time and pump energies. (e) Normalized spectral traces at 1 ps and different pump energies. (f) Changes in the zero-crossing points (energy position of  $\Delta OD = 0$ ) with the delay time and pump energies. The vertical red lines indicate the shift in energy (in meV) between 0.5 and 200 ps of delay times.

and the amount of shift does not increase linearly with the pump power; a deviation of  $\sim 4.0$  meV from linearity is observed when the number of incident photons is increased to four times (e.g., 8.4 meV at  $152.8 \mu\text{J cm}^{-2}$  and 12.4 meV at  $611.2 \mu\text{J cm}^{-2}$ ), suggesting that in addition to the carrier-carrier interactions, the phonons play an integral role in revealing such a giant spectral shift because the hot carriers transfer their energy to the phonons quickly after the photoexcitation.

To verify this phenomenon, we performed careful temperature-dependent PL spectroscopy and spectroscopic ellipsometry, and the results are presented in Fig. 3c and d. The steady-state PL measurements were conducted from 25 to  $90^\circ\text{C}$ ; the emission peak at  $\sim 2.27$  eV matches well with that reported previously<sup>44</sup> and undergoes a slight blue spectral shift upon heating (Fig. S2, ESI†). The PL intensity decreases to half as the temperature increases from 25 to  $90^\circ\text{C}$ . The normalized PL spectra shown in Fig. S3 (ESI†) display an 11 meV peak position difference with respect to the spectra measured at the lowest and highest temperatures, and the corresponding FWHM of the PL peak increases by  $\sim 13\%$  (Fig. S4, ESI†). We measured the dielectric function at different

energies and temperatures using variable angle spectroscopic ellipsometry (VASE) at  $65^\circ$ ,  $70^\circ$ , and  $75^\circ$  to increase accuracy, and the measured values were simultaneously fitted with an isotropic “B-spline” mode.<sup>45</sup> Fig. S5 (ESI†) shows the dielectric function measured at different energies and temperatures, and Fig. S6 (ESI†) shows the VASE data and their fittings at each temperature and angle. Both the real ( $\epsilon_1$ ) and imaginary ( $\epsilon_2$ ) parts of the dielectric function exhibit a downward and blueshifted trend in the range of 2.0–2.5 eV, although the behaviour at the high-energy side is different. Based on these  $\epsilon_1$  and  $\epsilon_2$ , we calculated the temperature-dependent absorption and refractive index in a wide spectral and temperature range from 25 to  $145^\circ\text{C}$  (thermogravimetric analysis confirmed the absence of weight loss until  $300^\circ\text{C}$ , see Fig. S7, ESI†). Fig. 3d shows the absorption spectra calculated at different temperatures, and the inset shows the exciton peak region zoomed-in from 2.25 to 2.50 eV. The exciton peak and onset of the absorption shift toward the high-energy side with the increasing temperature, accompanied by decreased intensity and broadened peak. This result is consistent with the observed TR-analysed derivative-like spectral shape and redshift with lattice





**Fig. 3** (a) Normalized pump-fluence-dependent spectral traces probed at 1 ps under 3.10 eV photoexcitation. (b) Zero-crossing point at different delay times and pump fluences. The vertical red lines indicate the shift in energy scale (in meV) between 1 and 50 ps of time delay. (c) PL spectra at different temperatures. The black dashed line indicates the PL peak changes with increasing temperature. (d) Calculated absorption of the MAPbBr<sub>3</sub> crystal as a function of temperature. The inset shows the first exciton peak zoomed-in from 2.25 to 2.50 eV. The black arrows show the changes with increasing temperature. (e) Electronic band structures of cubic-phase MAPbBr<sub>3</sub> and (f) calculated bandgaps of MAPbBr<sub>3</sub> as functions of lattice expansion. The inset shows the octahedral crystal structure obtained by single-crystal XRD measurements conducted at 25 °C. The Pb–Br atomic distances were measured at 25, 60 and 120 °C.

cooling (Fig. S8 shows the simulated differential absorption, which was determined by subtracting the absorption at high temperature from that at low temperature, ESI†). It has to be noted that the photo-induced reflectance response can be slightly different with the absorption, as the reflection coefficient  $R$  needs to be expressed in terms of the complex index of refraction, and the relation between  $\Delta n$  and the  $\Delta k$  which are the change of the real and imaginary parts of the complex refractive index, is essential for the interpretation of the differential reflectivity signal. Therefore, we retrieved the spectral evolution of  $R(\omega, t)$ , obtained by combining the steady-state  $R_s(\omega)$  calculated from ellipsometry and the  $\Delta R/R(t)$  data,<sup>33</sup>

$$R(\omega, t) = R_s(\omega) \times \frac{\Delta R}{R}(\omega, t) + R_s(\omega)$$

where  $R(\omega, t)$  is the reflectivity at the pump-probe delay  $t$  and the  $R_s(\omega)$  is the steady-state reflection spectrum obtained at room temperature, and the results are displayed in Fig. S9 (ESI†). The intensity of the reflectivity spectrum notably decreases at 0.1, 0.2, and 0.3 ps, but increases towards the equilibrium spectrum at stage-ii, as shown in Fig. S9b (ESI†). The photo-induced changes in  $R(\omega, t)$  are manifested through simultaneous changes in  $n(\omega)$  and  $\kappa(\omega)$ , therefore, the refractive index and absorption as a function of energy at different temperatures, extracted from VASE, are displayed in Fig. S9d and e (ESI†). With increasing the temperature, both the refractive index and absorption exhibit a downward trend of intensity at  $\sim 2.35$  eV and spectral blueshift, indicating that TR spectra primarily reflect the absorption/reflection difference of the

material with increased/decreased lattice temperatures, especially during the middle time period (stage-ii). The modification of the refractive index in MAPbBr<sub>3</sub> perovskite has been widely invoked to account for the large spectral changes in the positive transient signal above 2.35 eV,<sup>41,46,47</sup> however, it is important to note that both the photo-induced changes in absorption and refractive index stem from the same underlying phenomenon and are influenced by the lattice temperature, which, in turn, is governed by the coupling between carriers and phonons. This characteristic elucidates the fundamental origin of the positive transient features (Fig. 1 and 2), which are associated with the photo-induced BGR.

To further confirm the effect of hot-lattice on the electronic structure of MAPbBr<sub>3</sub>, we performed density functional theory (DFT) calculations using the generalized gradient approximation (GGA) and Perdew–Burke–Ernzerhof (PBE) functionals. The calculated electronic band structure of cubic-phase MAPbBr<sub>3</sub> and its bandgaps, determined as a function of the lattice expansion due to heating, are shown in Fig. 3e, f and Fig. S10 (ESI†). The MAPbBr<sub>3</sub> crystal exhibits a direct bandgap at the A-point, where the conduction band minimum originates from the Br-4p and Pb-6p states, and the valence band maximum results from the hybridization of the Br-4p and Pb-6s states. Without lattice expansion, the bandgap of MAPbBr<sub>3</sub> is 2.36 eV, which has a deviation of  $\sim 3\%$  with respect to our experimental results obtained by measuring the dielectric function at room temperature. Upon expanding the MAPbBr<sub>3</sub> lattice by 2%, a bandgap shift of 90 meV is observed. Such a BGR has been observed in several semiconductors, although most of them



show a decreased energy gap with increasing lattice temperature.<sup>48–50</sup> The inset in Fig. 3f displays the octahedral structure of the MAPbBr<sub>3</sub> crystal, as resolved by single-crystal X-ray diffraction (XRD) measurements, with the MA<sup>+</sup> cation removed for simplicity. The measured Pb–Br atomic distance is 3.037 Å at 25 °C, and increases to 3.136 and 3.278 Å at 60 and 120 °C, suggesting a  $\sim 3.2\%$  and  $\sim 7.9\%$  lattice expansion, respectively. The findings collectively indicate that despite the dominant contribution of the hot carrier interactions, the lattice heating/cooling in the stage-ii TR spectra plays a significant role in the observed asymmetric spectral evolution and redshift. This inference is supported by the early time behaviour (Fig. 1), which is governed by the interplay between carrier and lattice temperature exchanges following photoexcitation.

Furthermore, because of the unique phonon-driven BGR that can last for up to hundreds of picoseconds, we investigated its impact on electron–hole diffusion performance, as the ultrafast modification of the electronic structure may affect the transport properties of the photo-generated carriers. Therefore, a time-resolved SEM experiment was performed to evaluate the effect of carrier diffusion on the crystal surface. As shown in Fig. 4a, real-space imaging was performed using photon pump and electron probe pulses. In this experiment, 345 nm ultraviolet (UV) pulses were focused onto the tip of the gun source to generate high-energy (30 keV) pulsed electrons.



**Fig. 4** (a) Color-coded ultrafast SEM images after photoexcitation. The transient images were obtained at different delay times and diffusion distances. The upper part of the images shows a simplified diagram of the time-resolved SEM process. In this process, the MAPbBr<sub>3</sub> crystal was excited by a photon pulse with repetition rate of 6.25 MHz. The probe electron pulses were generated by focusing the UV photon pulses onto the tip of the gun source, and the secondary electrons that escaped from the surface were collected by the SE detector. The images were fitted with a 2D Gaussian function to increase the signal-to-noise ratio. (b) Pump-induced spot size evolution on the sample surface as a function of the delay time between the photon pump and the electron probe. The inset shows the transient SEM images obtained at different delay times after photoexcitation. The red dashed circles represent the pump footprint. (c) Normalized SE intensity changes with the delay time. The intensities were normalized by rescaling the maximum value of the data matrix to 1 and were calculated by summing the intensities in a selected square at the centre of the beam spot (see the inset, orange rectangle area).

For the excitation, a 515 nm visible pump beam was irradiated on the sample at 54° with respect to the direction of the pulse electron beam. The time-resolved secondary electron (SE) images were acquired by subtracting the excited signals from the unexcited (at negative time delays) ones. Fig. 4a shows the color-coded ultrafast SEM maps obtained at 3, 50, 200, 1000 and 2000 ps. Fig. 4b and c show the pump-induced spot size evolution and normalized SE kinetics as functions of the delay time. Based on the calculated evolution of these quasi-elliptical areas after the excitation, a  $\sim 7 \mu\text{m}$  diffusion length within 2 ns was determined on the surface of the MAPbBr<sub>3</sub> single crystal. However, the pump-induced SE spot rapidly intensified and expanded almost only within  $\sim 250$  ps, and the fitting results suggest a rising time of  $60.2 \pm 11.9$  ps, which well-matches with the decay timescale ( $67.1 \pm 2.8$  ps, Table S1, ESI†) at 2.40 eV (obtained by TR spectroscopy). As previously mentioned, the positive TR signal at 2.40 eV could be an indicator of temperature-induced effects in the material. Its shift and decay characteristics align with the time window of electron–hole diffusion, suggesting a strong correlation between the ultrafast modification of electronic structures and charge carrier diffusion. Although the underlying mechanism behind this carrier diffusion, primarily occurring during the photo-induced band-gap renormalization (BGR) period, remains elusive, one hypothesis suggests that carrier mobility and concentration can be altered during both nonequilibrium and equilibrium carrier–phonon interactions.<sup>23,51</sup> The temperature dependence of the charge carrier mobility can approach the expected form for acoustic deformation potential scattering ( $\mu \propto T^{-3/2}$ ),<sup>52–54</sup> where mobility increases with decreasing temperature. However, the exact functional dependence typically comprises a combination of multiple scattering mechanisms, making their individual identification challenging. Moreover, electron–phonon scattering imposes an upper limit on free charge mobility,<sup>54</sup> potentially prolonging the diffusion time and resulting in a trade-off behaviour. In this context, the carrier transport is initially limited but relative fast until approximately 250 ps, after which diffusion becomes negligible as both the carrier and lattice cool to a temperature that halts their functionality.

## Conclusions

Our study unveils the significant role of phonons in the transient restructuring of the band-edge in MAPbBr<sub>3</sub> single crystals following photoexcitation, in addition to the well-known contribution of photo-generated hot carriers. This phonon-driven transient BGR, occurring on a timescale commensurate with electron–hole diffusion, has not been previously considered in the context of the ultrafast modification of electronic structures in perovskite materials. Our findings contribute to a deeper understanding of the underlying physical phenomena in perovskite materials and emphasize the need to reassess existing theories regarding photo-induced BGR. By employing a comprehensive approach encompassing time-resolved and steady-state experimental techniques, as well as cutting-edge ultrafast



SEM and density functional theory (DFT) analysis, we have made valuable additions to the current knowledge on optoelectronic applications of perovskite materials. Furthermore, our results call for further investigations on other material systems to ascertain whether phonon-driven transient BGR is a general phenomenon in photo-induced processes.

## Experimental section

### Sample preparation and characterization

PbBr<sub>2</sub> (99.999%) and anhydrous dimethylformamide were purchased from Sigma-Aldrich, and methylammonium bromine (MABr) was obtained from Luminescence Technology Corp. The precursor MABr (0.748 g) was dissolved in anhydrous dimethylformamide (4 mL) in a 20 mL glass vial to form a clear solution. Then, PbBr<sub>2</sub> (2.452 g) was added into the glass vial with stirring to obtain a nearly saturated clear MAPbBr<sub>3</sub> solution. The glass vial was then placed onto a hotplate at 50 °C without disturbance for slow evaporation. Bulk MAPbBr<sub>3</sub> single crystals with dimensions in the centimetre range (see inset of Fig. S11, ESI†) were obtained from the solution after 12 h. These procedures were all performed inside a fume hood and were previously reported.<sup>55</sup> To examine the phase and orientation of the sample, XRD patterns were recorded at room temperature using a Bruker D8 ADVANCE diffractometer and Cu K $\alpha$  radiation ( $\lambda = 1.5406 \text{ \AA}$ ).

### TR measurements

The TR measurements were performed using a Helios pump-probe setup (Ultrafast Systems), which allowed a broadband visible probe upon a tuneable visible excitation of the samples. A 1 kHz 800 nm  $\sim 150 \text{ fs/7 mJ}$  laser pulse was split into two parts for the pump and probe. The pump was obtained using a nonlinear optical parametric amplifier (SpectraPhysics), which delivered pulses from  $\sim 350 \text{ nm}$  to  $\sim 700 \text{ nm}$ , and the probe was generated by focusing the rest of the 800 nm beam into a 2 mm CaF<sub>2</sub> crystal. Particularly, the white-light probe beam was further split into two beams; one was used as a reference to reduce the signal-to-noise ratio significantly. The pump and electronically-delayed probe were then spatially overlapped on the sample, and the reflected signal was collected and focused into a fibre detector. The detailed experimental setup and analysis software of the Helios system can be found elsewhere.<sup>56</sup>

### Fluence-dependent measurements

The fluence-dependent experiments were performed using the same TR set-up. The TR was measured at specific time delays, between the pump and probe, in a wide range of pump fluences. Prior to the measurement, we first determined the time zero position at the delay stage by analysing the point at which the signal appeared while electronically moving the delay stage. Next, we converted the desired delay time into distance on the stage and calculated the position of the stage with respect to zero time. Then, we set two time points slightly before and after the desired time, (e.g., the TR responses at

$\sim 9.9 \text{ ps}$  and  $\sim 10.1 \text{ ps}$  were measured if  $10 \text{ ps}$  is selected) and averaged the TR values obtained at these two time points.

The average incident laser fluence ( $F$ ; measured in  $\mu\text{J cm}^{-2}$ ) is defined as  $F = P/(r \cdot A)$ , where  $P$  is the average laser power,  $r$  is the repetition rate of the laser system (500 Hz), and  $A$  is the laser beam spot size. The laser beam spot size was measured using a camera-based beam profiling system consisting of a camera and analysis software (Ophir Photonics). The spot-size diameter was determined from the FWHM of the beam profile. We started the measurements with the lowest pump power that yielded a clear signal and used a round continuous neutral density filter to control and increase the power (caution must be taken as the perovskite can be easily damaged by lasers).

### Temperature-dependent *in situ* spectroscopic ellipsometry

Temperature-dependent *in situ* spectroscopic ellipsometry was performed using an M-2000 DI device (J. A. Woollam, USA), which operated in the 193–1690 nm wavelength range, coupled with an INSTEC heating stage, which allowed thermal scanning from room temperature up to 560 °C under a N<sub>2</sub> gas flow. The crystal was measured at a minimum of three angles of incidences (65°, 70°, and 75°), and the data analysis was performed using the Complete EASE 6.51 software package. The dielectric function was extracted using the Kramers–Kronig consistent B-spline optical model<sup>45</sup> (node resolution 0.1 eV). To calculate the absorption spectra and the reflectivity we used the relations:<sup>33</sup>

$$\alpha = \frac{4\pi k}{\lambda}, R = \frac{(1-n)^2 + k^2}{(1+n)^2 + k^2},$$

where  $n$  and  $k$  are, respectively, the real and imaginary parts of the complex refractive index  $\tilde{n} = n + ik$ :

$$n = \sqrt{\frac{\epsilon_1 + \sqrt{\epsilon_1^2 + \epsilon_2^2}}{2}}, k = \sqrt{\frac{-\epsilon_1 + \sqrt{\epsilon_1^2 + \epsilon_2^2}}{2}}.$$

For consistency, all the samples were modeled using exactly the same model to obtain the absorption coefficients and refractive indices at different temperatures.

### Temperature-dependent PL and Raman spectroscopy

The PL spectra were measured using a Horiba Fluoromax-4 spectrofluorometer with a photomultiplier (PMT-928). The crystal was placed into a heating cell with water flow. A temperature controller was installed to heat the water from room temperature to 90 °C. The temperature-dependent Raman spectra were acquired using a confocal Raman instrument (Witec Apyron). The temperature range was set to 25–145 °C, with 15 °C intervals, and a hotplate with liquid nitrogen was used to stabilize the temperature. A continuous-wave laser (wavelength: 633 nm), 300 grooves per mm grating, and Zeiss 50 $\times$ /0.55 objective lens were used for all the measurements. The laser power was fixed at 15 mW, and the integration time and accumulation number were 0.5 s and 10, respectively.

### Temperature-dependent single-crystal XRD

Variable-temperature single-crystal X-ray crystallographic data were collected on Bruker D8 Venture, using monochromatic Mo





K $\alpha$  ( $\lambda = 0.71073$  Å) radiation. Data reduction and cell refinements were performed with the Bruker SAINT Software package using a narrow-frame algorithm. The integration of the data using a cubic unit cell yielded a total of 3276 reflections to a maximum  $\theta$  angle of  $57.41^\circ$  ( $0.42$  Å resolution). Data were corrected for absorption effects using the Multi-Scan method (SADABS). The ratio of minimum to maximum apparent transmission was 0.283.

### Time-resolved SEM measurements

A femtosecond pulsed laser (Clark-MXR) with an infrared (IR) wavelength of 1030 nm was integrated with a modified scanning electron microscope (QUANTA 650). The beam generated by the IR laser (repetition rate: 6.25 MHz) was guided by mirrors to a 40/60 beam splitter, which divided the beam into two parts and then used for second and third harmonic generations. The green beam (515 nm) was sent to the scanning electron microscope and focused onto the sample to excite it. The UV beam was directed toward the tip of the gun source in the microscope to generate pulsed electrons rather than using continuously generated thermal electrons. An electronically controlled delay stage was used to move the pump pulse in the time-domain with respect to the probe. The accelerating voltage of the electron beam was 30 kV with a spot size of 7 and pump power of 5.5 mW. The footprint of the pump beam was obtained through a beam-on/beam-off step. The long and short axes were identified as  $\sim 30$  and  $\sim 20$   $\mu\text{m}$ , respectively. More detailed information about the set-up is available in ref. 57–59. To extract the SE dynamics, we first normalized the image by dividing the maximum value in the whole data matrix to avoid SE intensity fluctuations due to pulsed electrons and crossover propagation. Then, a rectangular area at the centre of the pump spot was selected to calculate the integrated intensity at each delay time to increase the accuracy.

### DFT calculations

We performed the DFT calculations using the projector-augmented wave method implemented in the Vienna *Ab Initio* Simulation Package code.<sup>60,61</sup> The GGA and PBE exchange-correlation functional were used, and van der Waals interactions were also included in the calculations using the zero-damping DFT-D3 method of Grimme. A uniform grid of  $6 \times 6 \times 6$   $k$ -mesh in the Brillouin zone was employed to optimize the crystal structure of cubic-phase MAPbBr<sub>3</sub>. The energy cutoffs of the wave functions were set to 500 eV for bulk MAPbBr<sub>3</sub>. The atomic positions of all the structures were fully relaxed until the Hellman–Feynman forces on each atom were less than  $0.01$  eV Å<sup>−1</sup>. For evaluating the hot-lattice effect on the electronic structure of MAPbBr<sub>3</sub>, the lattice parameters were expanded by 0.5, 1.0, 1.5, and 2.0%, respectively, to mimic the crystal structures at different temperatures.

## Author contributions

L. Wang: conceptualization, data curation, formal analysis, investigation, methodology, writing – original draft, writing – review &

editing; H. Wang: investigation, methodology; R. Nughays: data curation, investigation, methodology; W. Ogieglo: data curation, methodology; J. Yin: data curation, formal analysis, methodology; L. Gutiérrez-Arzaluz: data curation, methodology; X. Zhang: methodology; J. Wang: investigation, methodology; I. Pinnau and O. Bakr: supervision, writing – review & editing; O. F. Mohammed: investigation, supervision, writing – original draft, writing – review & editing.

## Conflicts of interest

The authors declare no competing interests.

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